

MR2006C LDMOS TRANSISTOR

Document Number: MR2006C
Objective Datasheet V1.1

24W, 12.5V High Power RF LDMOS FETs

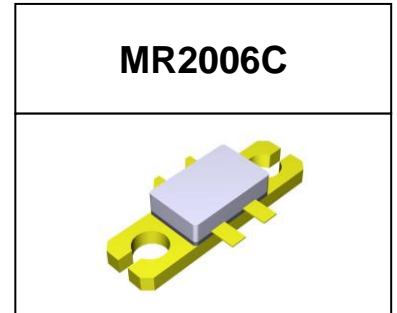
Description

The MR2006C is a 24-watt, Push-Pull configuration, unmatched LDMOS FETs, designed for ISM and Mobile radio applications with frequencies under 2GHz. It can be used in Class AB/B and Class C for all typical modulation formats.

It can also operate at 13.6V, 14V etc with increased power capability.

- Typical Performance (On Innogration fixture with device soldered):

$V_{DD} = 12.5$ Volts, $I_{DQ} = 200$ mA, CW.



Freq(MHz)	Pin(dBm)	Pout(dBm)	Pout(W)	IDS(A)	Gain(dB)	Eff(%)
100	28.5	43.7	23.4	2.81	15.2	66.7%
150	26.4	43.6	22.9	2.71	17.2	67.6%
200	27.9	44	25.1	2.92	16.1	68.8%
250	26.8	43.6	22.9	2.69	16.8	68.1%
300	25.3	43.3	21.4	2.36	18	72.5%
350	25.9	43.1	20.4	2.3	17.2	71.0%
400	26.3	43	20.0	2.4	16.7	66.5%
450	25.4	42.9	19.5	2.35	17.5	66.4%
500	26	42.9	19.5	2.33	16.9	66.9%

Features

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Excellent thermal stability, low HCI drift
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

Suitable Applications

- HF Amplifier
- UHF Amplifier
- Vehicle radio
- VHF Amplifier
- Wideband Amplifier
- Beidou Navigation

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain--Source Voltage	V_{DSS}	+65	Vdc
Gate--Source Voltage	V_{GS}	-10 to +10	Vdc
Operating Voltage	V_{DD}	+32	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_c	+150	°C
Operating Junction Temperature	T_j	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case $T_c = 85^\circ\text{C}$, $T_j = 200^\circ\text{C}$, DC test	$R_{\theta JC}$	0.9	°C/W

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Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22--A114)	Class 2

Table 4. Electrical Characteristics ($T_A = 25\text{ }^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
DC Characteristics (per half section)					
Drain-Source Voltage $V_{GS}=0, I_{DS}=1.0\text{mA}$	$V_{(BR)DSS}$	65	69		V
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ V}, V_{GS} = 0\text{ V}$)	I_{DSS}	---	---	1	μA
Gate--Source Leakage Current ($V_{GS} = 9\text{ V}, V_{DS} = 0\text{ V}$)	I_{GSS}	---	---	1	μA
Gate Threshold Voltage ($V_{DS} = 28\text{V}, I_D = 600\text{ }\mu\text{A}$)	$V_{GS(th)}$	---	1.95	---	V
Common Source Input Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 14\text{ V}, f = 1\text{ MHz}$)	C_{ISS}		24.8		pF
Common Source Output Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 14\text{ V}, f = 1\text{ MHz}$)	C_{OSS}		14.0		pF
Common Source Feedback Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 14\text{ V}, f = 1\text{ MHz}$)	C_{RSS}		0.65		pF
Common Source Input Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 28\text{ V}, f = 1\text{ MHz}$)	C_{ISS}		24.6		pF
Common Source Output Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 28\text{ V}, f = 1\text{ MHz}$)	C_{OSS}		10.6		pF
Common Source Feedback Capacitance ($V_{GS} = 0\text{V}, V_{DS} = 28\text{ V}, f = 1\text{ MHz}$)	C_{RSS}		0.53		pF

Functional Tests (On Demo Test Fixture, 50 ohm system) $V_{DD} = 12.5\text{ Vdc}, I_{DQ} = 200\text{ mA}, f = 500\text{ MHz}, \text{CW Signal Measurements}, \text{Pin}=26\text{dBm}$

Power Gain	G_p		16.9		dB
Drain Efficiency@Pout	η_D		66		%
Output Power	P_{out}		19.5		W
Input Return Loss	IRL		-7		dB

Load Mismatch (In Innogration Test Fixture, 50 ohm system): $V_{DD} = 12.5\text{Vdc}, I_{DQ} = 200\text{ mA}, f = 500\text{ MHz}$

VSWR 10:1 at 19.5W pulse CW Output Power	No Device Degradation
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TYPICAL CHARACTERISTICS

Figure 1: Power gain and drain efficiency as function of Pulse output power

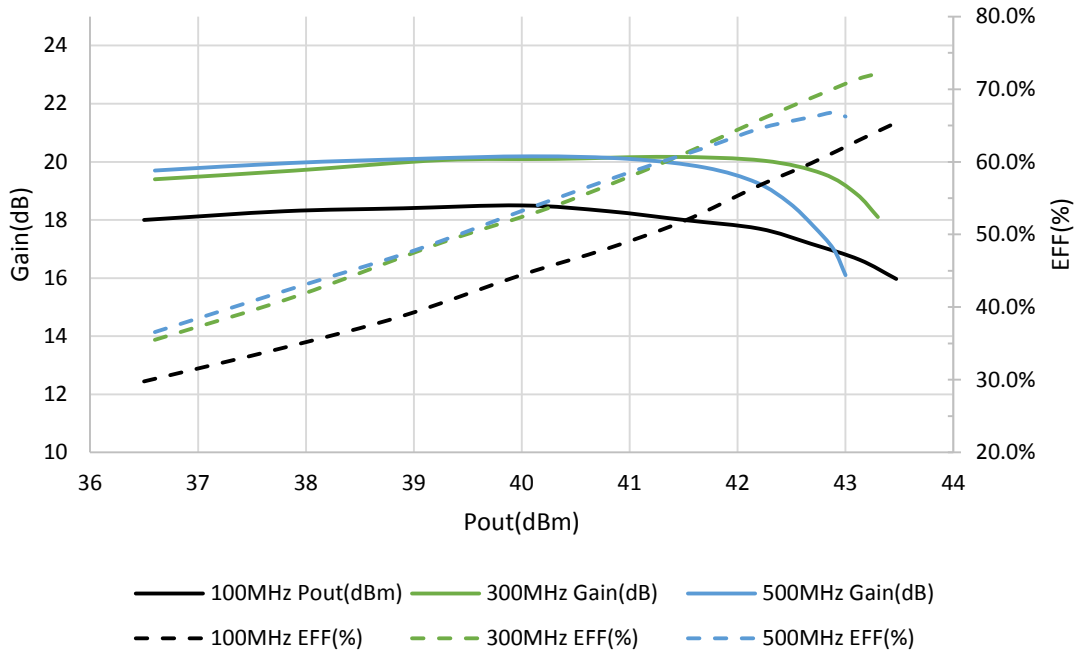
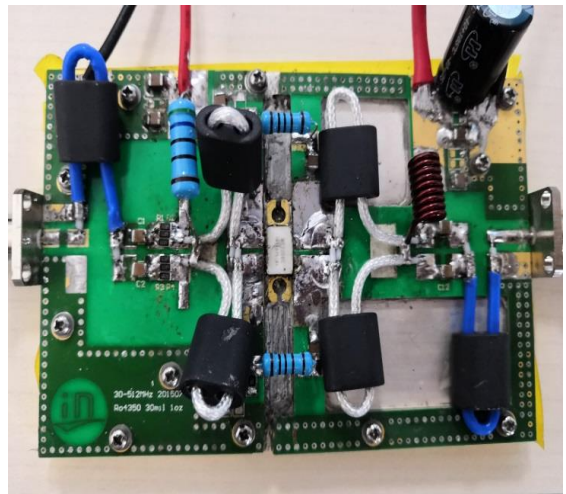
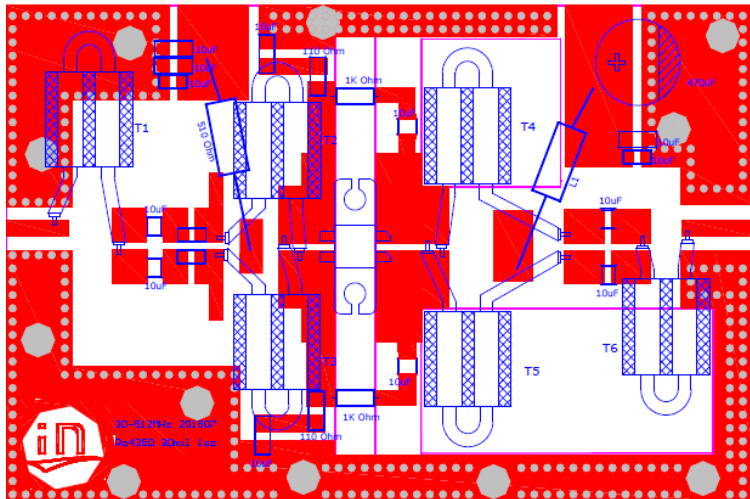


Figure 2: 108-512MHz wideband application circuit picture
(PCB Materials: Roger 4350B, 30Mil, Layout file upon request)



BOM	
L1	6uH 5A air core inductance
T1, T6	magnetic core: BN-61-102 RF cable: SF-086-50, 70mm length
T2, T3,	magnetic core: BN-61-102
T4, T5	RF cable: SFF-25-1.5, 70mm length

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Package Outline

Flanged ceramic package; 2 mounting holes; 4 leads

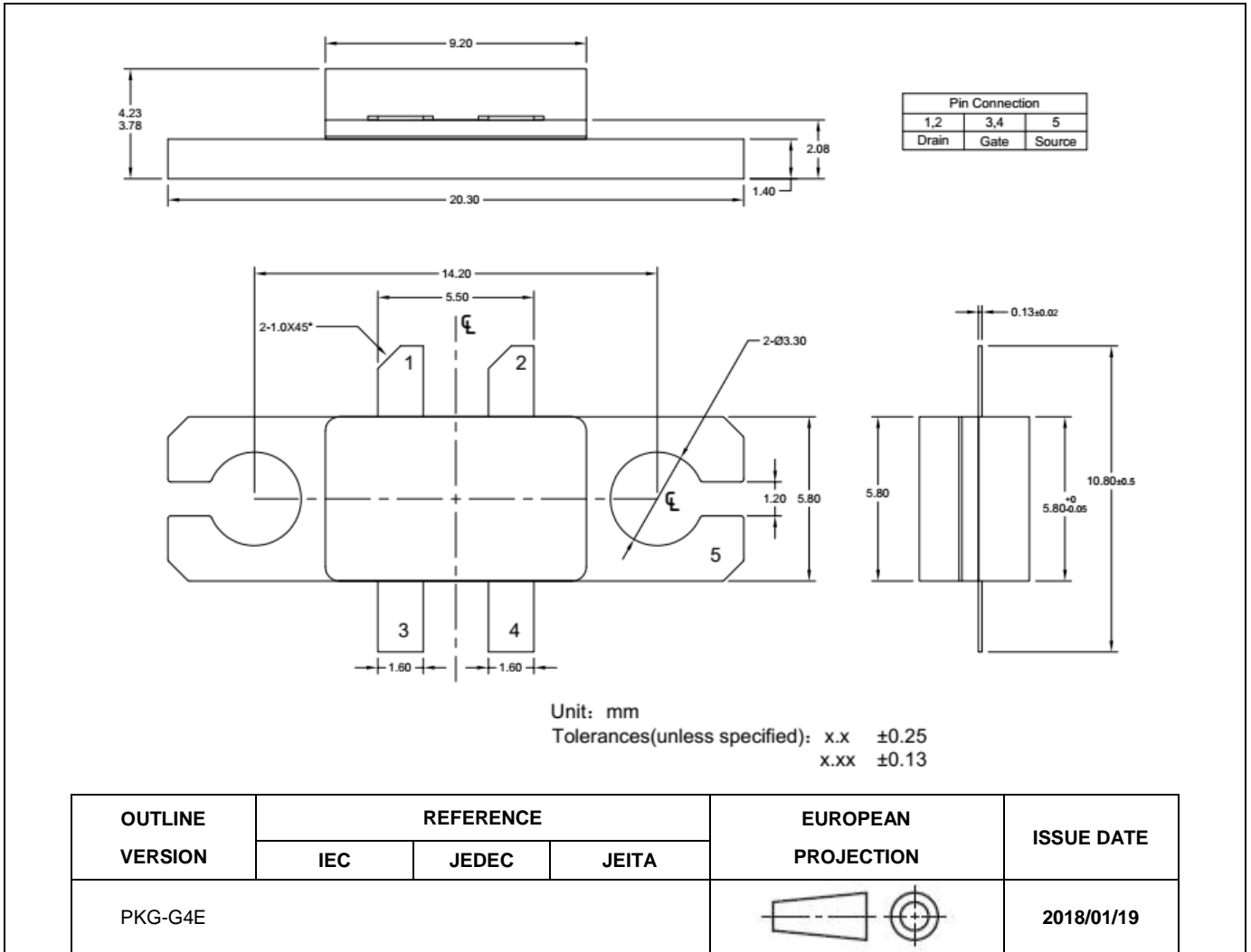


Figure 1. Package Outline PKG-G4E

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Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2018/6/14	Rev 1.0	Objective Datasheet
2018/9/16	Rev 1.1	Preliminary Datasheet

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